

**Vishay Siliconix** 

RoHS

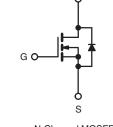
COMPLIANT



#### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	100			
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	0.27		
Q <sub>g</sub> (Max.) (nC)	16			
Q <sub>gs</sub> (nC)	4.4			
Q <sub>gd</sub> (nC)	7.7			
Configuration	Single			





N-Channel MOSFET

#### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Lead (Pb)-free	IRFD123PbF
	SiHFD123-E3
SnPb	IRFD123
	SiHFD123

<b>ABSOLUTE MAXIMUM RATINGS (TA</b>	= 25 °C, unless otherwis	se noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	100	N		
Gate-Source Voltage	V <sub>GS</sub>	± 20	- V		
Continuous Drain Current	$V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_A = 25 \text{ °C}}{T_A = 100 \text{ °C}}$		1.3		
Continuous Drain Current	$V_{GS}$ at 10 V $T_A = 100 \text{ °C}$	ID	0.94	А	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	10	1		
Linear Derating Factor		0.0083	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	100	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	1.3	А		
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	0.13	mJ	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	PD	1.3	W	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175		
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	- °C	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD}$  = 25 V, starting T<sub>J</sub> = 25 °C, L = 22 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 2.6 A (see fig. 12).

c.  $I_{SD} \leq 9.2$  A, dl/dt  $\leq 110$  A/µs,  $V_{DD} \leq V_{DS}, \, T_J \leq 175$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	120	°C/W

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$		-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	ce to 25 °C, I <sub>D</sub> = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25	μA
		V <sub>DS</sub> = 80 V	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}$	I <sub>D</sub> = 0.78 A <sup>b</sup>	-	-	0.27	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.78 A <sup>b</sup>		0.80	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V V <sub>DS</sub> = 25 V f = 1.0 MHz, see fig. 5		-	360	-	pF
Output Capacitance	Coss			-	150	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	34	-	
Total Gate Charge	Qg		I <sub>D</sub> = 9.2 A, V <sub>DS</sub> = 80 V see fig. 6 and 13 <sup>b</sup>	-	-	16	nC
Gate-Source Charge	$Q_gs$	$V_{GS} = 10 V$		-	-	4.4	
Gate-Drain Charge	$Q_gd$			-	-	7.7	
Turn-On Delay Time	t <sub>d(on)</sub>			-	6.8	-	
Rise Time	t <sub>r</sub>	Vpp	$V_{DD} = 50 \text{ V}, \text{ I}_{D} = 9.2 \text{ A}$		27	-	- ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 18 \Omega, R_D = 5.2 \Omega, \text{ see fig. } 10^{b}$		-	18	-	
Fall Time	t <sub>f</sub>			-	17	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	24
Internal Source Inductance	L <sub>S</sub>			-	6.0	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the	MOSFET symbol showing the		-	1.3	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	p - n junction diode		-	-	10	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	, $I_{\rm S}$ = 1.3 A, $V_{\rm GS}$ = 0 V <sup>b</sup>	-	-	2.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 9.2 A, dl/dt = 100 A/µs <sup>b</sup>		-	130	260	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.65	1.3	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	-on is dor	ninated b	$V_{\rm S}$ and	Ln)	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



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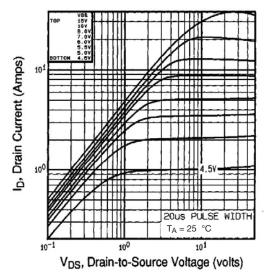


Fig. 1 - Typical Output Characteristics,  $T_A = 25 \ ^\circ C$ 

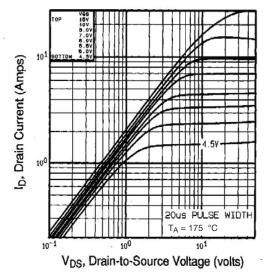
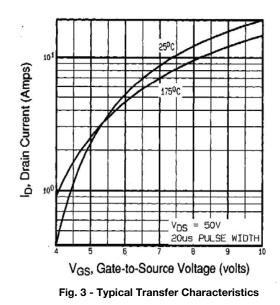


Fig. 2 - Typical Output Characteristics,  $T_A = 175 \ ^\circ C$ 



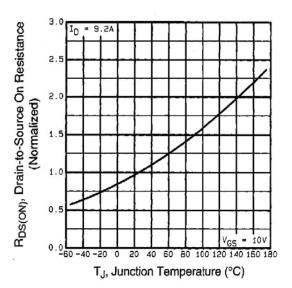


Fig. 4 - Normalized On-Resistance vs. Temperature

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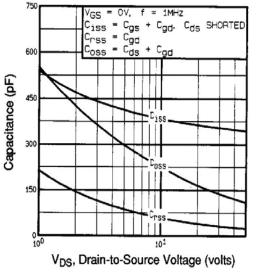


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

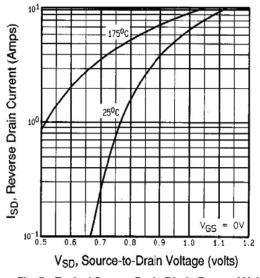


Fig. 7 - Typical Source-Drain Diode Forward Voltage

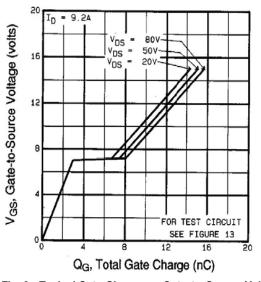
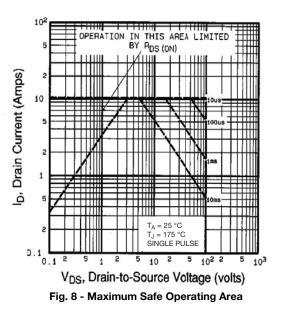


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





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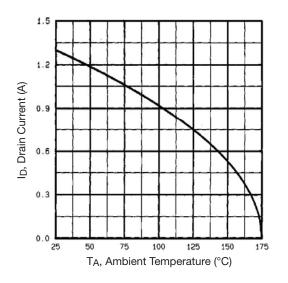


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

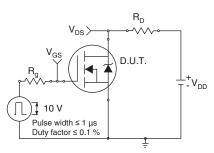


Fig. 10a - Switching Time Test Circuit

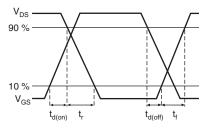


Fig. 10b - Switching Time Waveforms

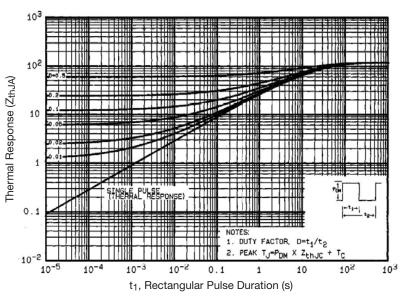


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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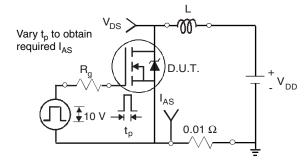


Fig. 12a - Unclamped Inductive Test Circuit

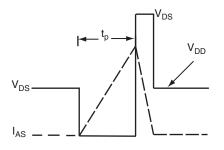


Fig. 12b - Unclamped Inductive Waveforms

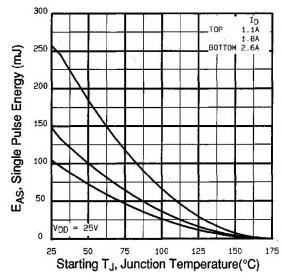
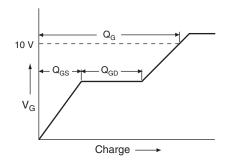


Fig. 12c - Maximum Avalanche Energy vs. Drain Current







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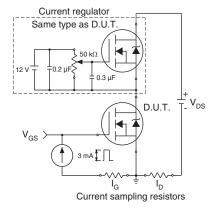
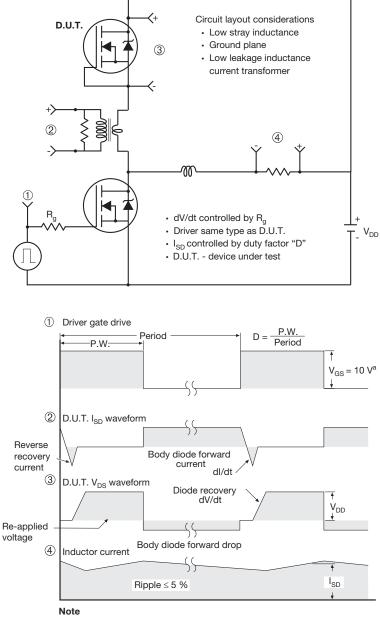


Fig. 13b - Gate Charge Test Circuit



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#### Peak Diode Recovery dV/dt Test Circuit



a.  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel

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